

Post-mortem diagnostics for the Taiwan Light Source

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> NSRRC accelerator facility

Taiwan Light Source (TLS) and Taiwan Photon Source (TPS)

- > Operation status of the TLS (poster WEPC058)
- > Tools to capture data for post-mortem analysis
- Some trip scenarios analysis
- > Summary



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(Courtesy of Google Earth)









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WEPC082 WEPC104 WEPC113 WEPC114 WEPC142 THPP143



TLS beamline status





- > 301 mA Top-Up operation
- > ~ 0.05% photon flux constancy were achieved routinely
- > > 98 % availability achieved



- Keeping high stability and high availability is our commitment to the users
- How to achieve this?



Bad experience - one of an example

Problem of master oscillator related problem



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Bad experience - one of an example - cont.

Trilogy of the abnormal high trip rate in (February - December, 2000)





Proverb

久病成良醫 (三折肱成良醫)

Failure is the Mother of Success (失敗是成功之母) Experience is the Mother of Wisdom (經驗是智慧之母) Fall into a moat and you will gain wisdom from the experience (吃一塹長一智) Fall Down Seven Times, Get Up Eight (七転八起) Success comes from experience; but experience comes from failure (Mark Twain)

Strategies to improve or to keep high availability

Preventative maintenance Identify weaknesses of the system and remove them Operation automation Analyze each trip event to identify where is the problem => Fault diagnostic Capture data before and after specific event happened => Post-mortem analysis Many measures were done after identify the real reasons for further improvement!



All tools are trigged by the sum signal: beam trip + superconducting IDs quench + SRF trip + predefined trigger conditions



How to detect beam loss?



Superconducting insertion device quench detection





Recorder, oscilloscope, and b-by-b feedback processor, t-by-t BPM

Recorder



Data memory in bunch-by-bunch feedback processor



Oscilloscope



Post-mortem buffer of BPM electronics





cPCI based high density digitizer





VME based fast digitizer







Linac klystron stand arcing diagnostics





- Try to understand the reasons of every RF/SRF fault

• What we experience a lot...

- SRF "quench" due to fast change of beam behaviors...
 - Fast beam dump or partial beam loss due to various reasons;
 - Fast beam dump due to kicker misfired;
 - Orbit change;
 - ...
- LLRF's feedback loop becomes unstable due to heavy beam loading...
- False alarm by window arcing...
- We experience with a "new" kind of trip event every few months and usually solve it by reducing various feedback loop gains.
- Modified many LLRF electronics to avoid false alarm.
- What we never or seldom experience...
 - Multipacting in the cold surface waveguide (Pf < 70 kW);
 - Real quench or field emission (rf gap voltage < 1.6 MV);
 - Vacuum burst due to hydrogen desorption (vacuum better than 0.7 nTorr);



SRF trip due to mismatch of beam loaded cavity



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SRF trip due to mismatch of beam loaded cavity - kicker misfired



SRF Trip due to mismatch of beam loaded cavity - SW6 fault



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Feedback loop oscillations due to heavy beam loading





The beam trip caused by kicker misfired



Trip caused by the SWLS main power supply failed



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Trip caused by the SWLS main power supply failed - cont.

SWLS Trip Event on 19-Oct-2006 17:52;41



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SW6 and IASW-R6 quench - I

SID Trip Event on 25-Sep-2007



SW6 and IASW-R6 quench - II (SW6 quench)





Time (sec)

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SW6 and IASW-R6 quench - III (SW6 quench)

SID Trip Event on 25-Sep-2007 14:03:52



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SW6 and IASW-R6 quench - IV (IASW-R6 quench)

SID Trip Event on 25-Sep-2007 14:04:34



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SW6 and IASW-R6 quench - V (IASW-R6 quench)

SID Trip Event on 25-Sep-2007 14:04:34



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- > 25-Sep-2007 14:03:51 SW6 quench.
 - * SW6 quench happened.
 - * MPS output dropped to 0 (before PLC interlock tripped MPS).
- > 25-Sep-2007 14:04:34 IASW-R6 quench.
 - * Partial beam loss happened during injection instance.
 - * IASW-R6 quench.
 - * PLC interlock tripped MPS.
- Unknown reason caused SW6 quench, then partial beam loss at every injection instance, then IASW-R6 quench.
- Many improvements were done: coil winding (poster WEPC114), liquid He filling procedure, interlock logic modification...

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Beam loss induced IASW-R6 trip (2008/04/15 06:57)



IASW-R6



Reason: one vertical corrector PS failed



Kicker diagnostic

Kicker diagnostic (VME digitizer working in segmented capture mode)

Maintenance test



Normal top-up injection





Libera Brilliance post-mortem data (turn-by-turn) Diagnostics node (10 KHz rate for ~ 10 sec) is in implementation



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Horizontal Spectrogram



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- > Several different tools are available.
- Some occasions have helped to identify some peculiar events.
- However no all events can explanation.
 => further efforts are essential !
- > Simple automatic signal analysis are supported.

Our current efforts

- Better integration of various diagnostic tools with the control system.
- > Archive the events.
- > Develop automatic analysis tools to search various signals.
- > Develop better user interface.
- > Automatic report generation.



Summary

- Taiwan Light Source (TLS) is current operated at 301 mA top-up operation. Top-up operation at 360 mA was commissioning.
 => Poster WEPC043 (stable beam up to 400 mA has been tested)
- > Photon flux constancy can be kept around ~ 0.05%.
- \succ Availability is achieved 97 ~ 99% routinely.
- > To provide user better service, reduce trip rate is an important routine job.
- > Improving reliability, availability and serviceability is still on going.
- > All of the experiences will help the reliability and availability design for the newly proposed Taiwan Photon Source.
 - => Reliability design for various subsystem.

=> Post-mortem buffer are expected embedded in BPM electronics, superconducting insertion devices' controller, LLRF system, power supply controller, FOFB diagnostic node, ... etc.



We learn and get helps from accelerator community a lot.

Thank You

Hope we can contribute something!

Thank You for Your Attention!